	Application No.	Applicant(s)	=
	09/901,688	VERDREL-LAHAXE ET AL.	
Notice of Allowability	Examiner	Art Unit	
	Brian P Mruk	1751	
The MAILING DATE of this communication appeal All claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R	(OR REMAINS) CLOSED in or other appropriate community in the community is application in the community in the community is application in the community in the	n this application. If not included unication will be mailed in due course. THIS	/e
1. \boxtimes This communication is responsive to <u>December 17, 2003</u> .			
2. The allowed claim(s) is/are 1-10 and 12-35.			
3. The drawings filed on are accepted by the Examine	r.		
 4. Acknowledgment is made of a claim for foreign priority ur a) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority documents have International Bureau (PCT Rule 17.2(a)). * Certified copies not received: 	been received. been received in Application	on No	
Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONM THIS THREE-MONTH PERIOD IS NOT EXTENDABLE.	of this communication to file ENT of this application.	e a reply complying with the requirements	
 A SUBSTITUTE OATH OR DECLARATION must be submit INFORMAL PATENT APPLICATION (PTO-152) which give 	itted. Note the attached EX es reason(s) why the oath o	AMINER'S AMENDMENT or NOTICE OF r declaration is deficient.	
6. CORRECTED DRAWINGS (as "replacement sheets") mus (a) including changes required by the Notice of Draftspers 1) hereto or 2) to Paper No./Mail Date (b) including changes required by the attached Examiner's Paper No./Mail Date ldentifying indicia such as the application number (see 37 CFR 1. each sheet. Replacement sheet(s) should be labeled as such in the deposit of the de	on's Patent Drawing Review S Amendment / Comment on the Market according to 37 CF sit of BIOLOGICAL MATI	r in the Office action of he drawings in the front (not the back) of FR 1.121(d). ERIAL must be submitted. Note the	
Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☐ Notice of Draftperson's Patent Drawing Review (PTO-948)		formal Patent Application (PTO-152)	
•	Paper No.	ummary (PTO-413), Mail Date	
 Information Disclosure Statements (PTO-1449 or PTO/SB/06 Paper No./Mail Date 12-17-03 		Amendment/Comment	
4. Examiner's Comment Regarding Requirement for Deposit		Statement of Reasons for Allowance	
of Biological Material	9. ☐ Other	Brian P. Mwl Brian P Mruk Primary Examiner Art Unit: 1751	

Art Unit: 1751

REASONS FOR ALLOWANCE

1. The following is an examiner's statement of reasons for allowance:

Instant claims 1-10 and 12-35 are allowable for the reasons of record found in Applicant's Remarks dated December 11, 2003 and December 17, 2003. Specifically, applicant has provided a certified translation of their French Priority Document, which antedates Koike et al, EP 1,051,964.

Accordingly, the claims viewed as a whole would not have been obvious to one of ordinary skill in the art at the time of the invention after viewing the prior art of record.

- 2. Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."
- 3. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Brian Mruk whose telephone number is (571) 272-1321. The examiner can normally be reached on Monday-Thursday from 7:00 AM to 5:30 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Yogendra Gupta, can be reached on (571) 272-1316. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9306.

BAM

Brian Mruk March 3, 2004

> Brian P. Mruk Primary Examiner Tech Center 1700

Brian P. Mulk